CDMA 1X Right Cheek High

Electronics: DAE3 Sn536

Communication System: CDMA 1X-new Frequency: 848.31 MHz Duty Cycle: 1:1

Probe: ET3DV6 - SN1736 ConvF(6.51, 6.51, 6.51)

Cheek High/Area Scan (51x81x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 1.01 mW/g

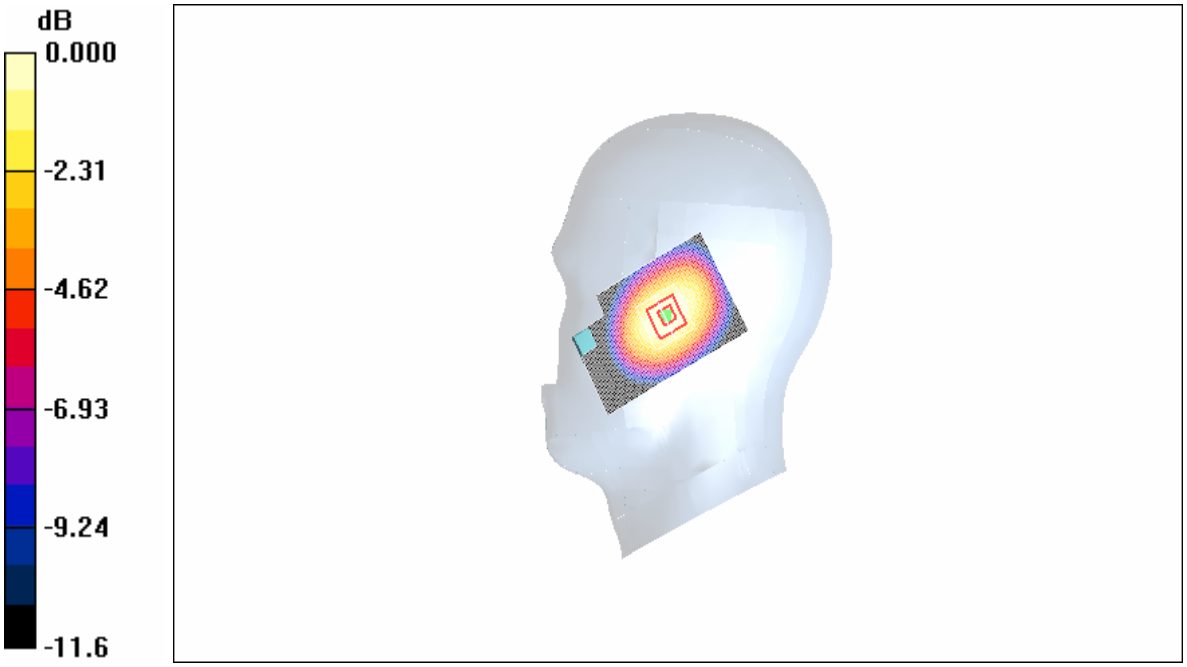
Cheek High/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 25.3 V/m; Power Drift = -0.200 dB

Peak SAR (extrapolated) = 1.20 W/kg

SAR(1 g) = 0.851 mW/g; SAR(10 g) = 0.566 mW/g

Maximum value of SAR (measured) = 0.908 mW/g



0 dB = 0.908mW/g

Fig. 13 Right Hand Touch Cheek CDMA 835MHz CH777

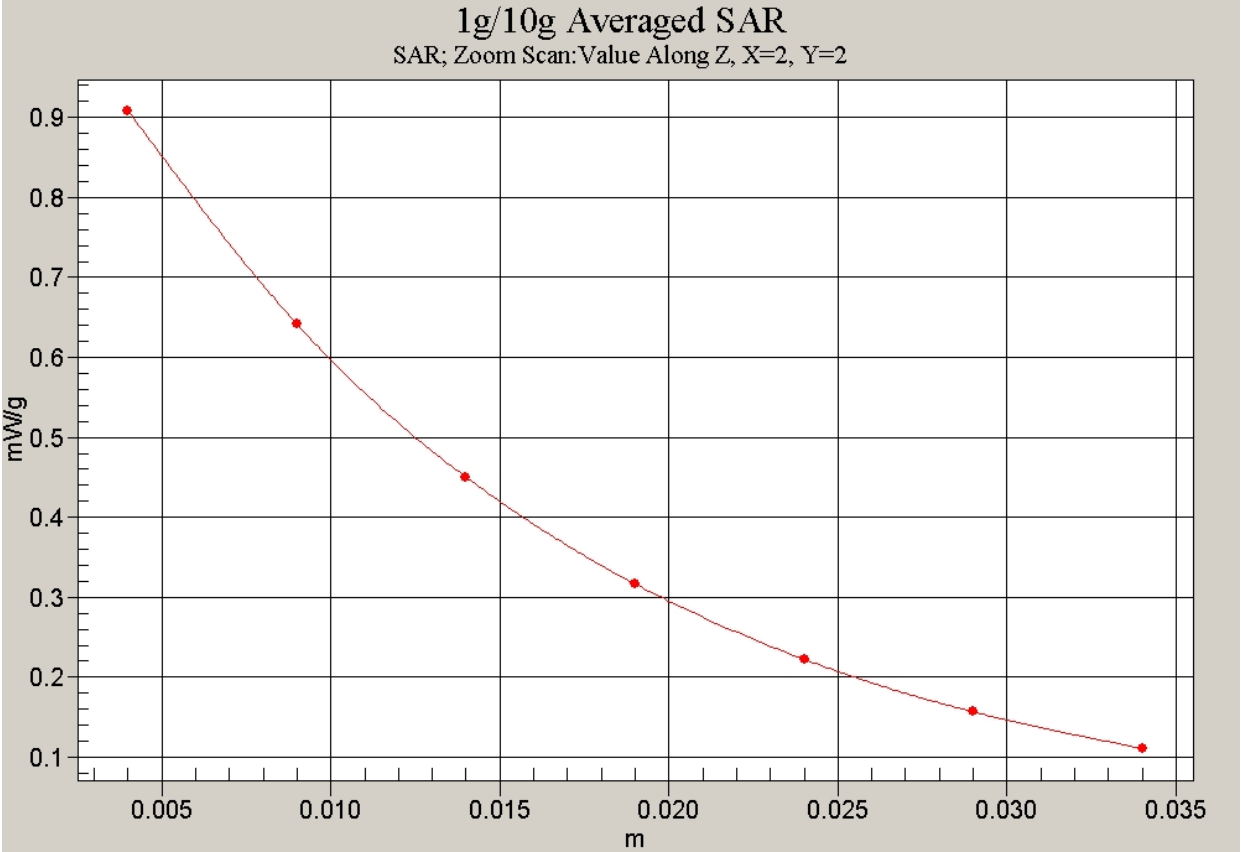


Fig. 14 Z-Scan at power reference point (CDMA 835MHz CH777)

CDMA 1X Right Cheek Middle

Electronics: DAE3 Sn536

Communication System: CDMA 1X-new Frequency: 836.52 MHz Duty Cycle: 1:1

Probe: ET3DV6 - SN1736 ConvF(6.51, 6.51, 6.51)

Cheek Middle/Area Scan (51x81x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.837 mW/g

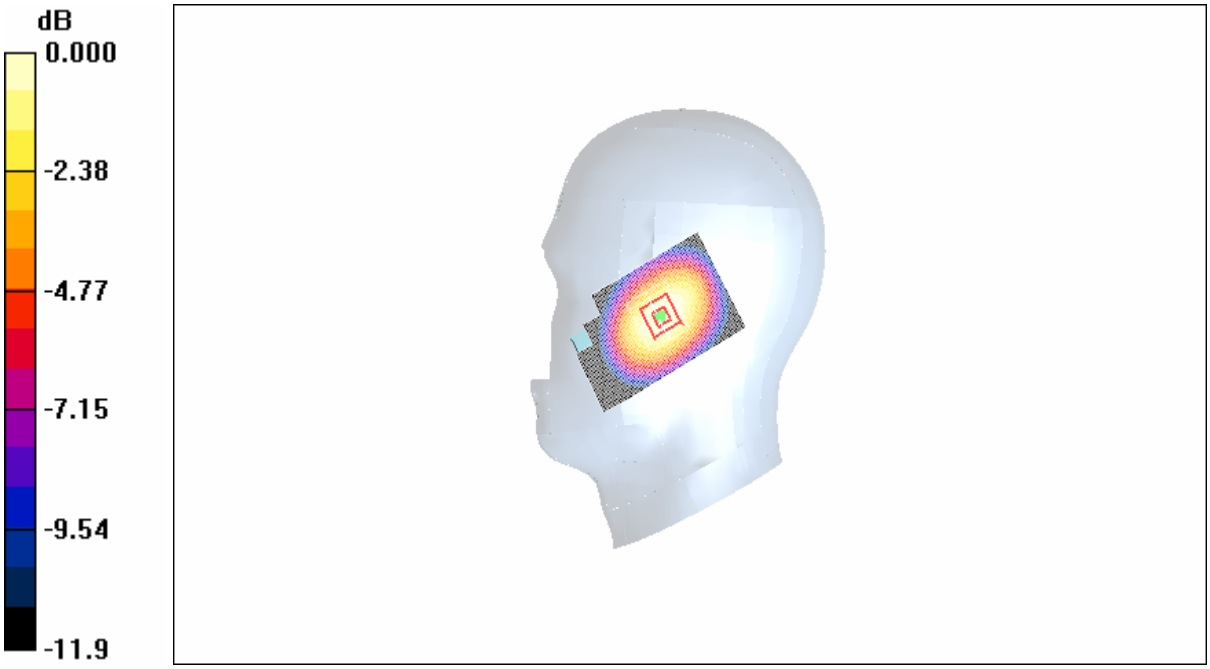
Cheek Middle/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 22.3 V/m; Power Drift = -0.200 dB

Peak SAR (extrapolated) = 1.03 W/kg

SAR(1 g) = 0.732 mW/g; SAR(10 g) = 0.486 mW/g

Maximum value of SAR (measured) = 0.790 mW/g



0 dB = 0.790mW/g

Fig.15 Right Hand Touch Cheek CDMA 835MHz CH384

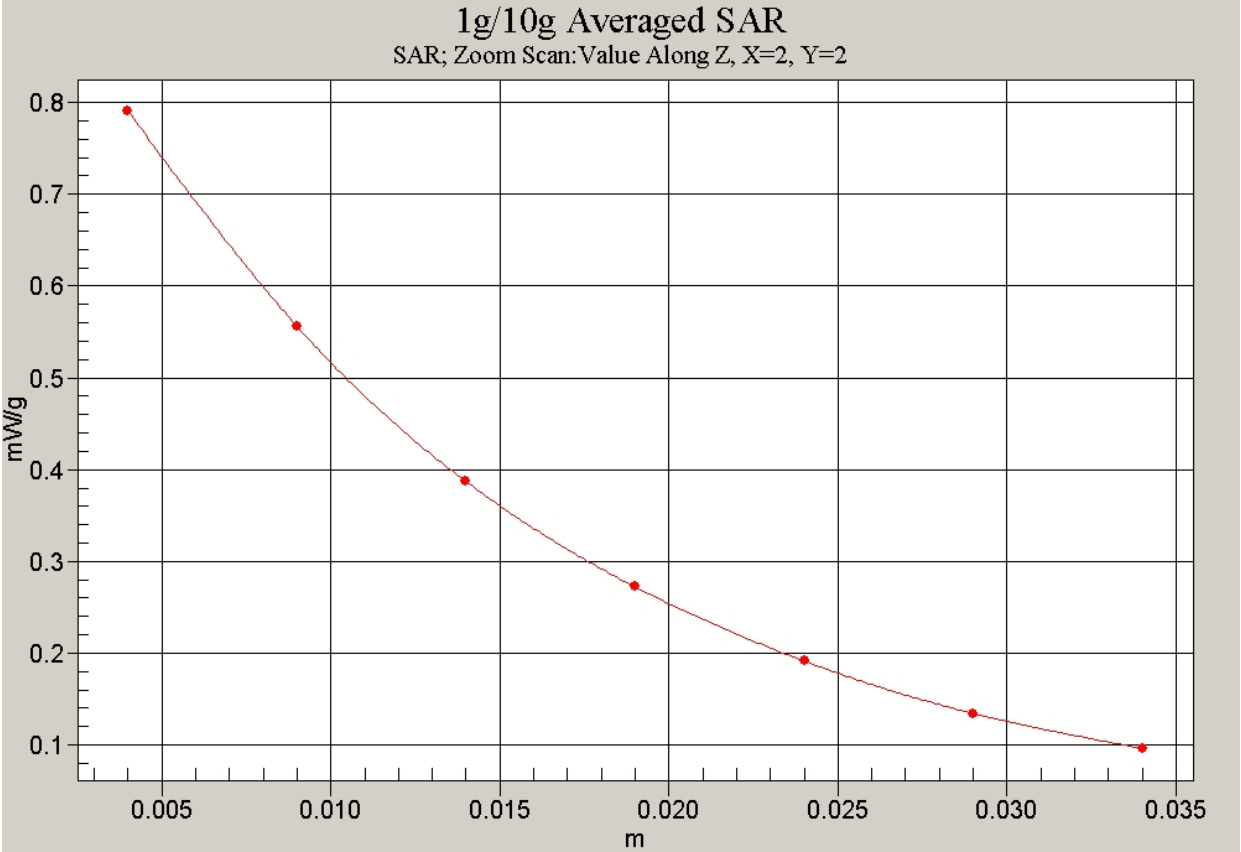


Fig. 16 Z-Scan at power reference point (CDMA 835MHz CH384)

CDMA 1X Right Cheek Low

Electronics: DAE3 Sn536

Communication System: CDMA 1X-new Frequency: 824.7 MHz Duty Cycle: 1:1

Probe: ET3DV6 - SN1736 ConvF(6.51, 6.51, 6.51)

Cheek Low/Area Scan (51x81x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 1.03 mW/g

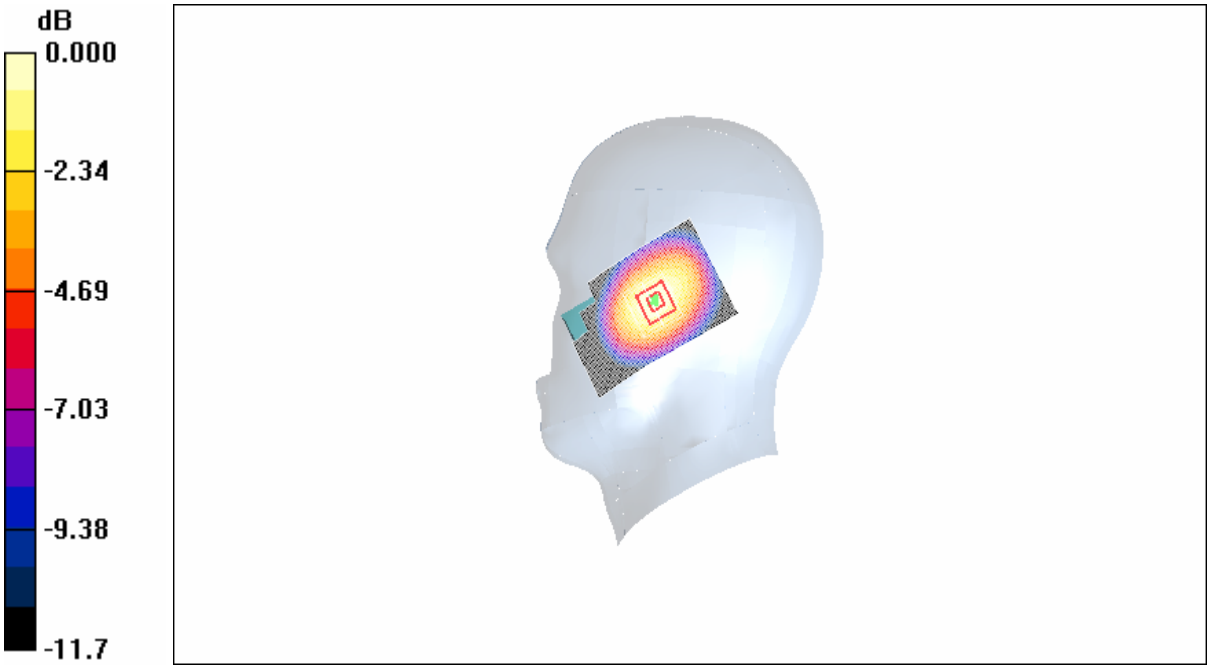
Cheek Low/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 24.6 V/m; Power Drift = 0.138 dB

Peak SAR (extrapolated) = 1.35 W/kg

SAR(1 g) = 0.965 mW/g; SAR(10 g) = 0.644 mW/g

Maximum value of SAR (measured) = 1.03 mW/g



0 dB = 1.03mW/g

Fig. 17 Right Hand Touch Cheek CDMA 835MHz CH1013

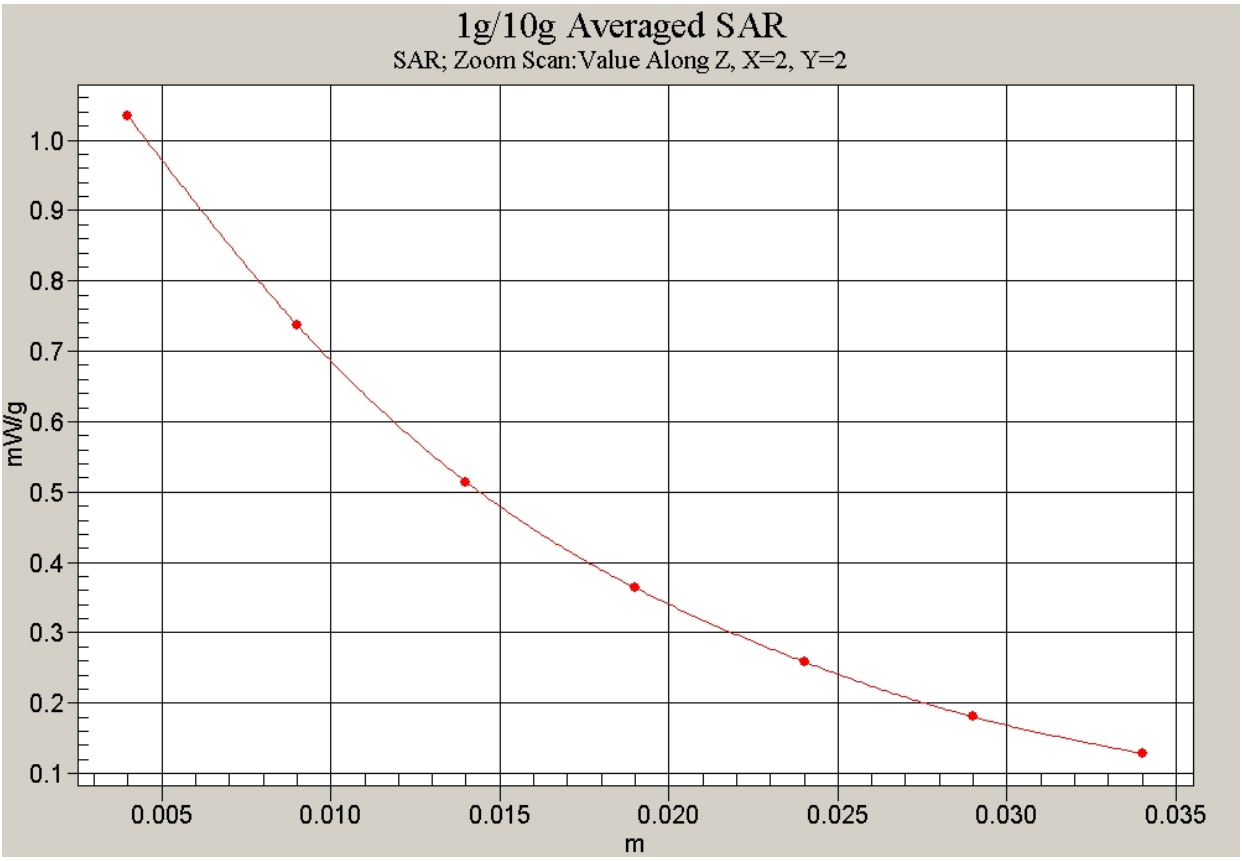


Fig. 18 Z-Scan at power reference point (CDMA 835MHz CH1013)

CDMA 1X Right Tilt High

Electronics: DAE3 Sn536

Communication System: CDMA 1X-new Frequency: 848.31 MHz Duty Cycle: 1:1

Probe: ET3DV6 - SN1736 ConvF(6.51, 6.51, 6.51)

Tilt High/Area Scan (51x81x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.495 mW/g

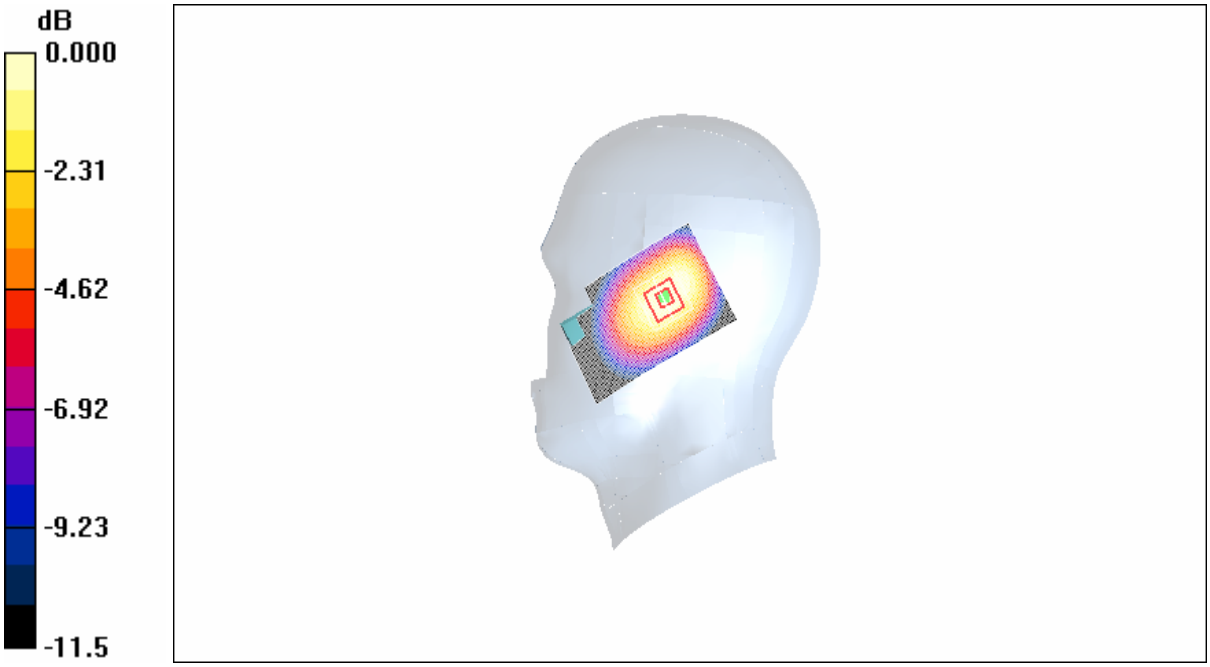
Tilt High/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 20.9 V/m; Power Drift = -0.200 dB

Peak SAR (extrapolated) = 0.632 W/kg

SAR(1 g) = 0.447 mW/g; SAR(10 g) = 0.298 mW/g

Maximum value of SAR (measured) = 0.480 mW/g



0 dB = 0.480mW/g

Fig. 19 Right Hand Tilt 15°CDMA 835MHz CH777

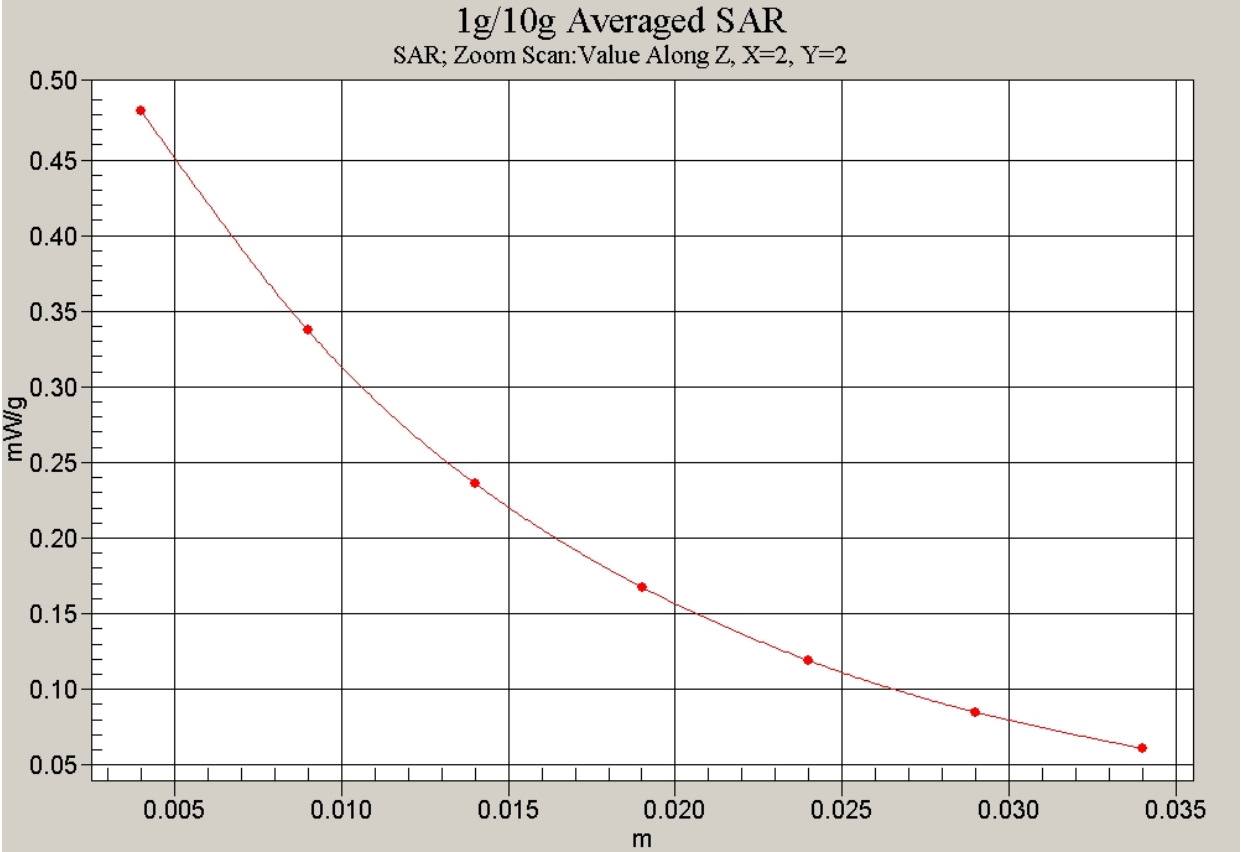


Fig. 20 Z-Scan at power reference point (CDMA 835MHz CH777)

CDMA 1X Right Tilt Middle

Electronics: DAE3 Sn536

Communication System: CDMA 1X-new Frequency: 836.52 MHz Duty Cycle: 1:1

Probe: ET3DV6 - SN1736 ConvF(6.51, 6.51, 6.51)

Tilt Middle/Area Scan (51x81x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.461 mW/g

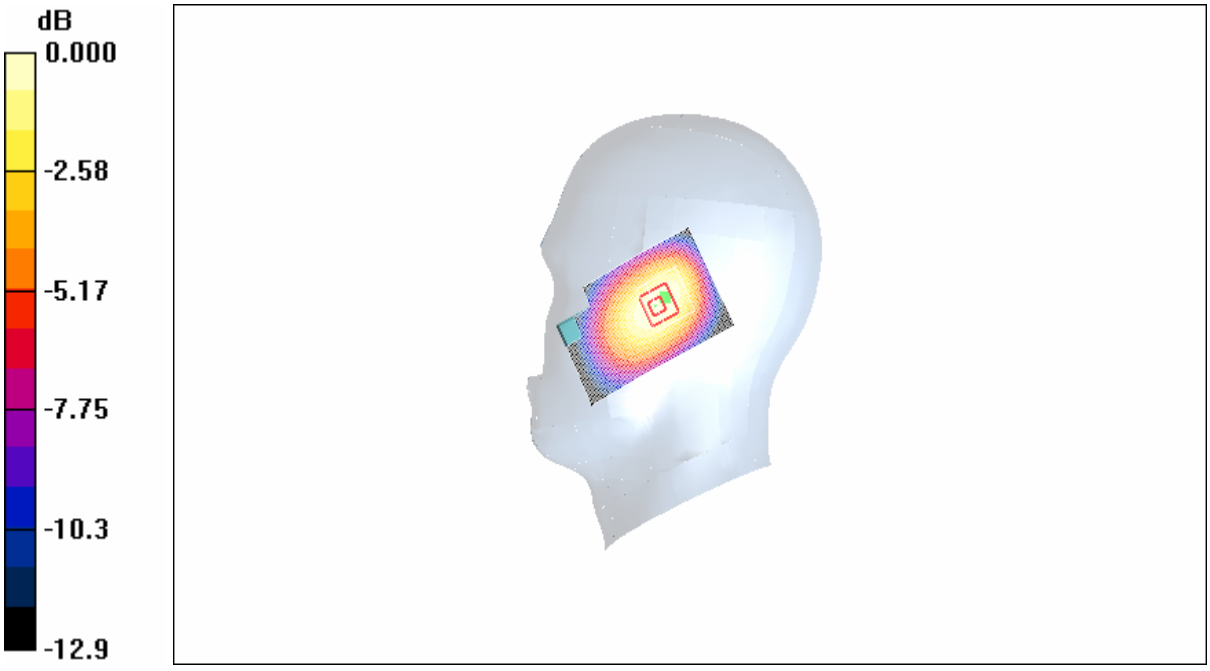
Tilt Middle/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 18.2 V/m; Power Drift = -0.200 dB

Peak SAR (extrapolated) = 0.564 W/kg

SAR(1 g) = 0.402 mW/g; SAR(10 g) = 0.270 mW/g

Maximum value of SAR (measured) = 0.431 mW/g



0 dB = 0.431mW/g

Fig. 21 Right Hand Tilt 15°CDMA 835MHz CH384

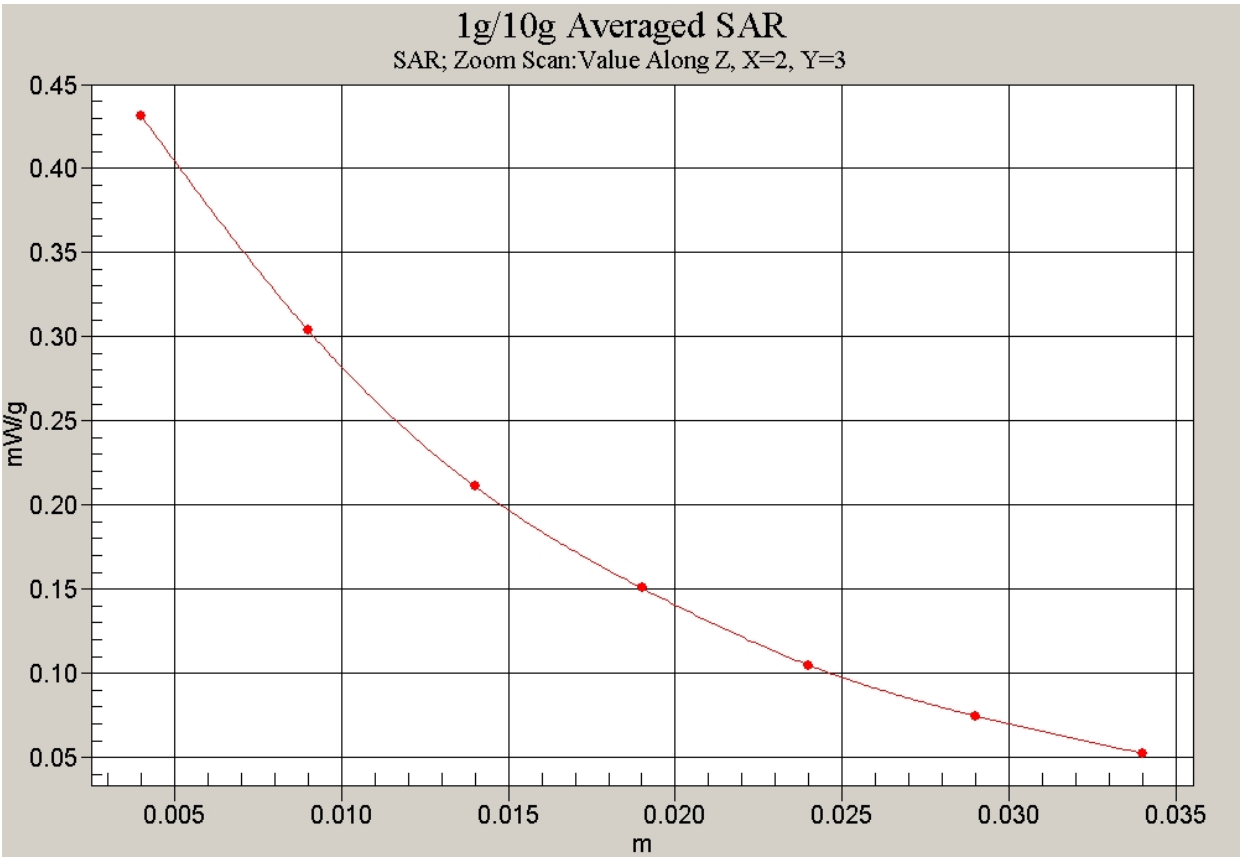


Fig. 22 Z-Scan at power reference point (CDMA 835MHz CH384)

CDMA 1X Right Tilt Low

Electronics: DAE3 Sn536

Communication System: CDMA 1X-new Frequency: 824.7 MHz Duty Cycle: 1:1

Probe: ET3DV6 - SN1736 ConvF(6.51, 6.51, 6.51)

Tilt Low/Area Scan (51x81x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.624 mW/g

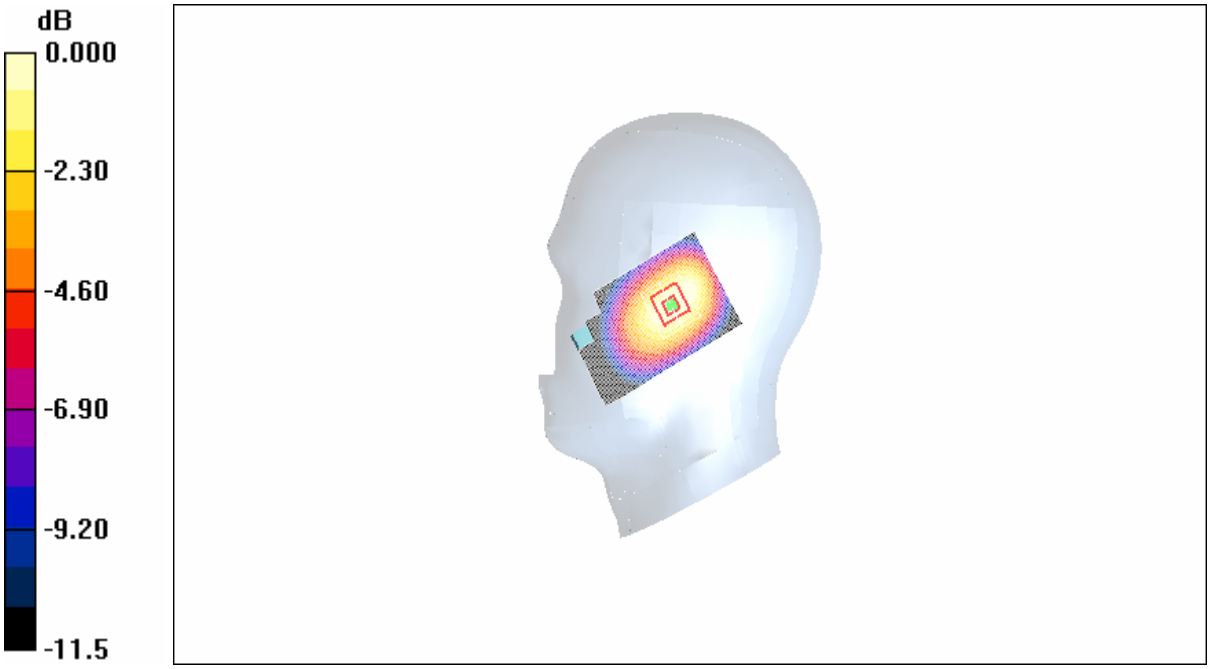
Tilt Low/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 24.3 V/m; Power Drift = -0.171 dB

Peak SAR (extrapolated) = 0.800 W/kg

SAR(1 g) = 0.578 mW/g; SAR(10 g) = 0.390 mW/g

Maximum value of SAR (measured) = 0.627 mW/g



0 dB = 0.627mW/g

Fig. 23 Right Hand Tilt 15°CDMA 835MHz CH1013

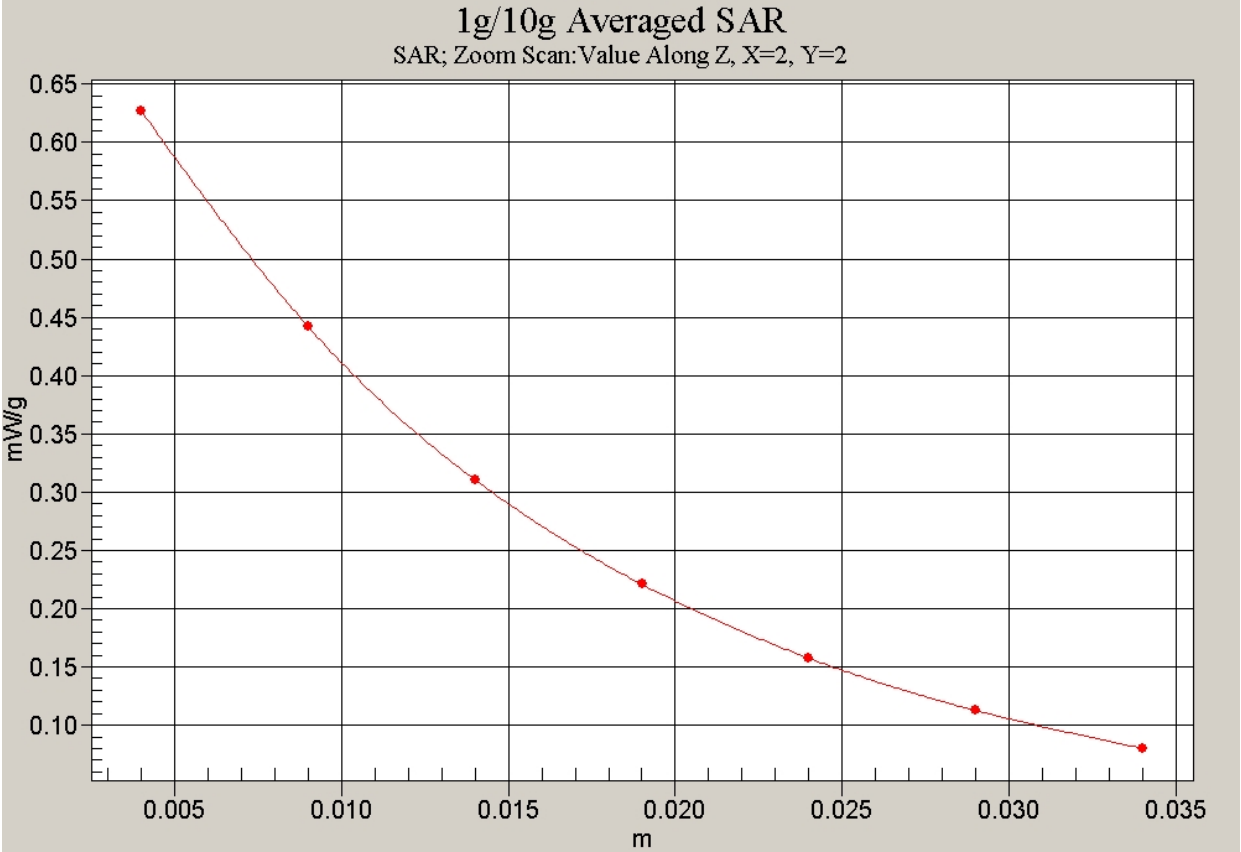


Fig. 24 Z-Scan at power reference point (CDMA 835MHz CH1013)

CDMA 1X Body Toward Phantom High

Electronics: DAE3 Sn536

Communication System: CDMA 1X-new Frequency: 848.31 MHz Duty Cycle: 1:1

Probe: ET3DV6 - SN1736 ConvF(6.45, 6.45, 6.45)

Toward Phantom High/Area Scan (71x121x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.334 mW/g

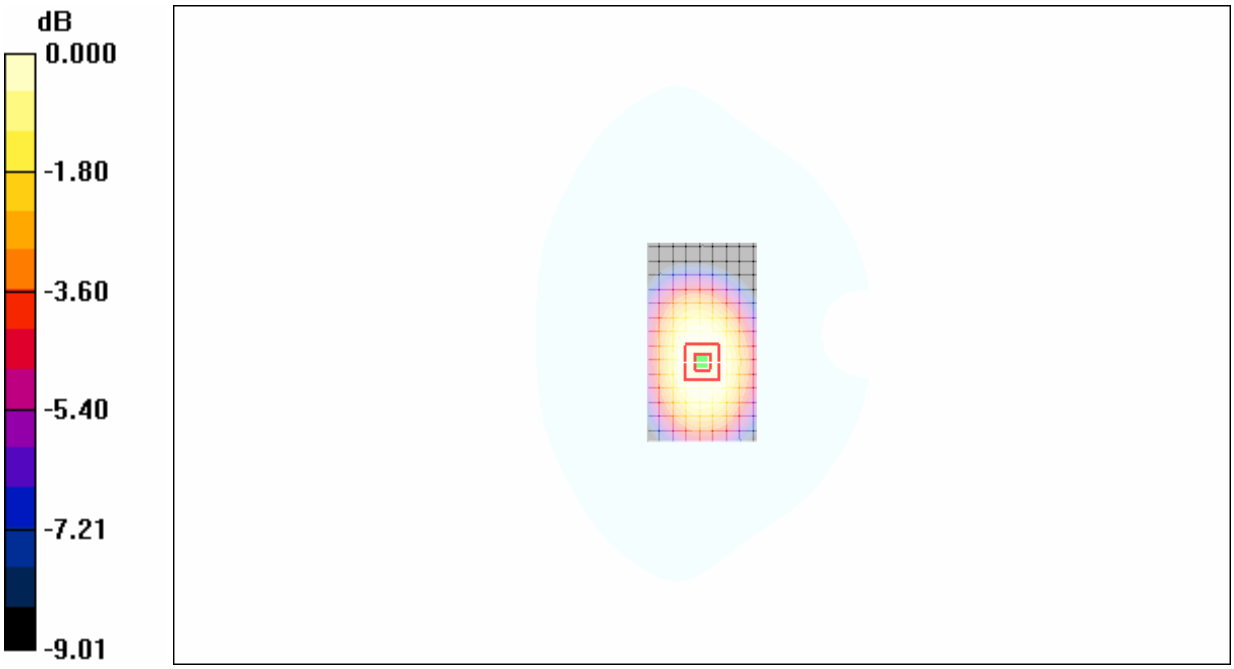
Toward Phantom High/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 19.5 V/m; Power Drift = -0.200 dB

Peak SAR (extrapolated) = 0.348 W/kg

SAR(1 g) = 0.271 mW/g; SAR(10 g) = 0.195 mW/g

Maximum value of SAR (measured) = 0.289 mW/g



0 dB = 0.289mW/g

Fig. 25 CDMA 835MHz, Body, Towards Phantom, CH777

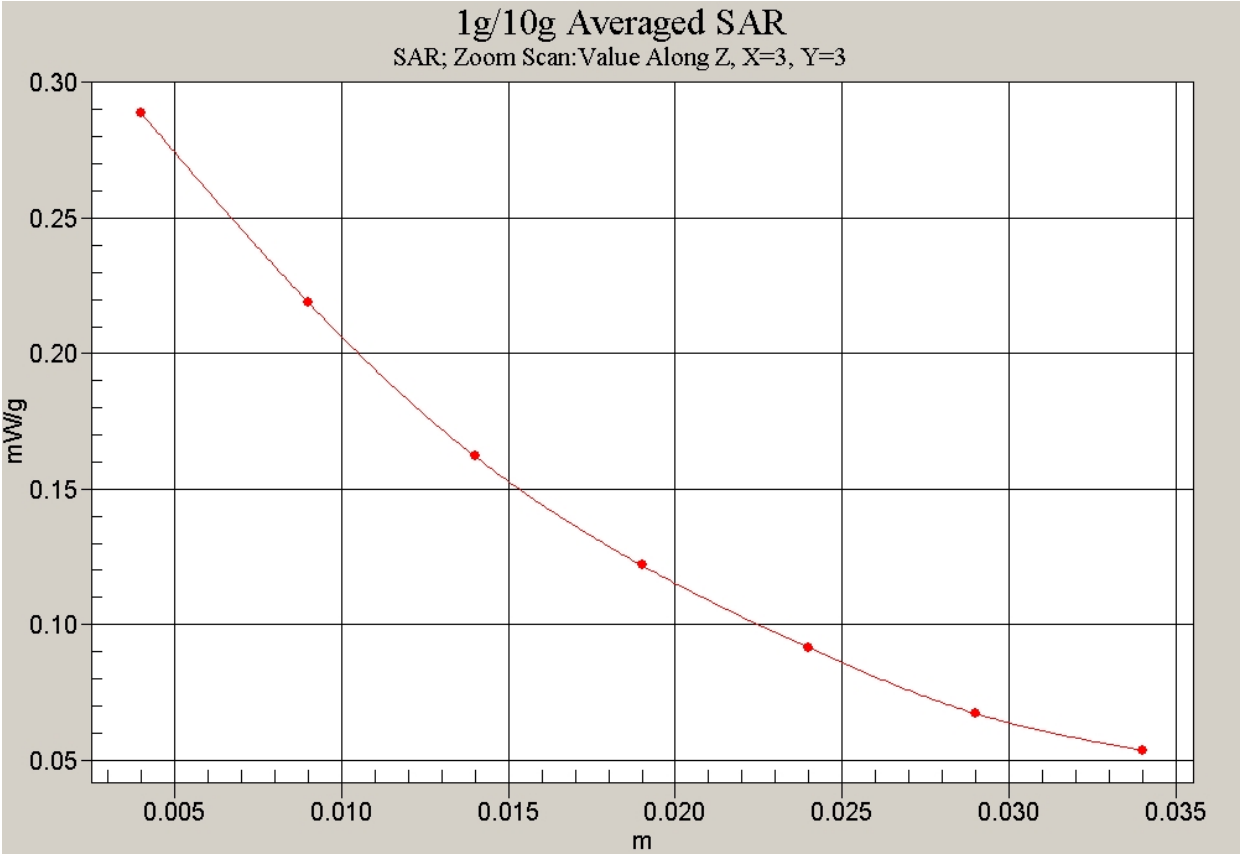


Fig. 26 Z-Scan at power reference point (CDMA 835MHz, Body,Towards Phantom, CH777)

CDMA 1X Body Toward Phantom Middle

Electronics: DAE3 Sn536

Communication System: CDMA 1X-new Frequency: 836.52 MHz Duty Cycle: 1:1

Probe: ET3DV6 - SN1736 ConvF(6.45, 6.45, 6.45)

Toward Phantom Middle/Area Scan (71x121x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.318 mW/g

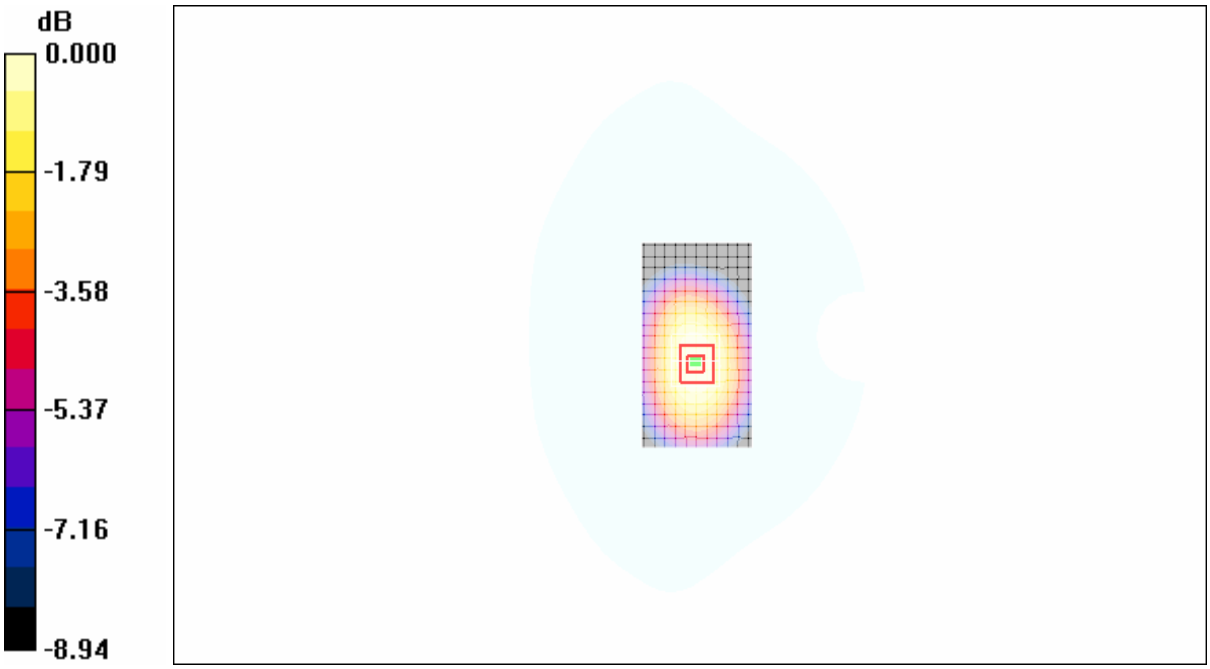
Toward Phantom Middle/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 18.1 V/m; Power Drift = -0.188 dB

Peak SAR (extrapolated) = 0.373 W/kg

SAR(1 g) = 0.290 mW/g; SAR(10 g) = 0.209 mW/g

Maximum value of SAR (measured) = 0.307 mW/g



0 dB = 0.307mW/g

Fig. 27 CDMA 835MHz, Body, Towards Phantom, CH384

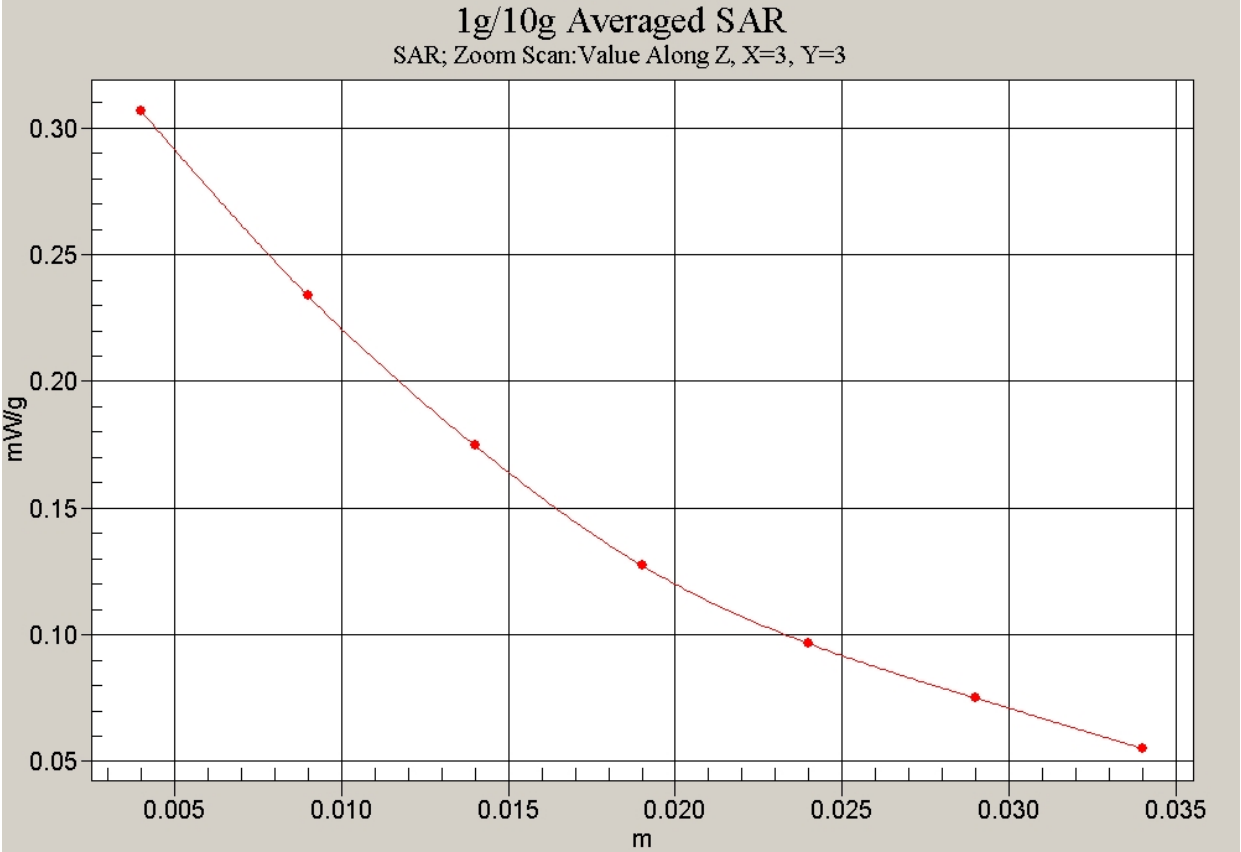


Fig. 28 Z-Scan at power reference point (CDMA 835MHz, Body, Towards Phantom, CH384)

CDMA 1X Body Toward Phantom Low

Electronics: DAE3 Sn536

Communication System: CDMA 1X-new Frequency: 824.7 MHz Duty Cycle: 1:1

Probe: ET3DV6 - SN1736 ConvF(6.45, 6.45, 6.45)

Toward Phantom Low/Area Scan (71x121x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.350 mW/g

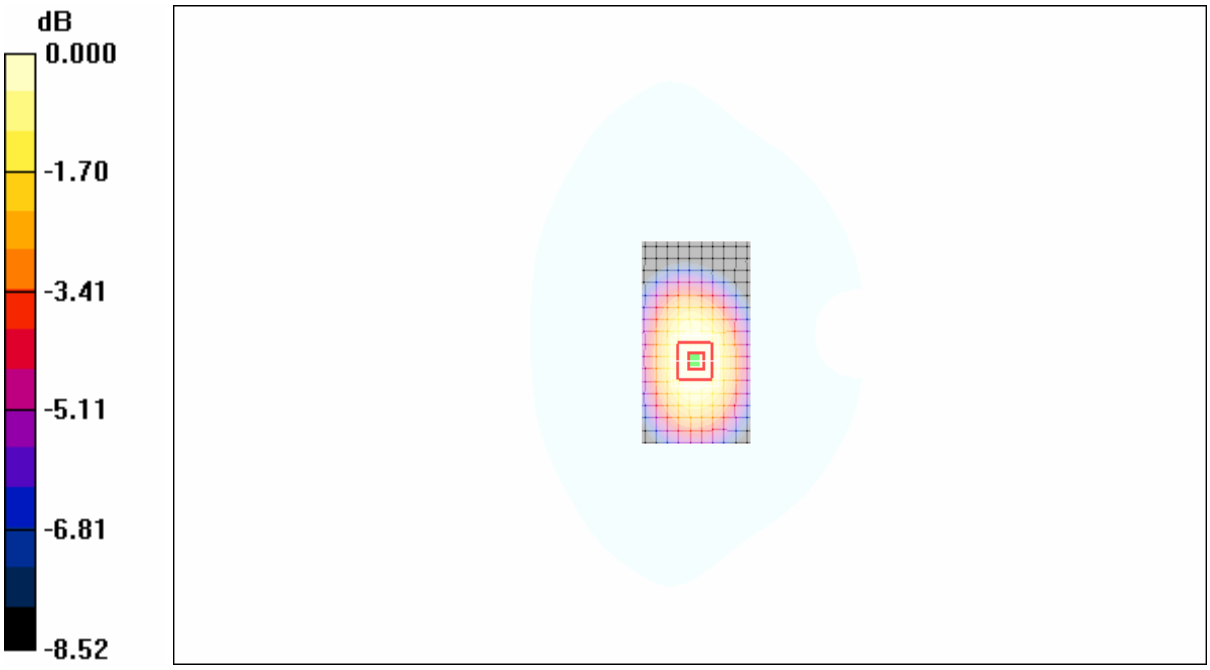
Toward Phantom Low/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 19.4 V/m; Power Drift = -0.200 dB

Peak SAR (extrapolated) = 0.406 W/kg

SAR(1 g) = 0.317 mW/g; SAR(10 g) = 0.229 mW/g

Maximum value of SAR (measured) = 0.336 mW/g



0 dB = 0.336mW/g

Fig. 28 CDMA 835MHz, Body, Towards Phantom, CH1013

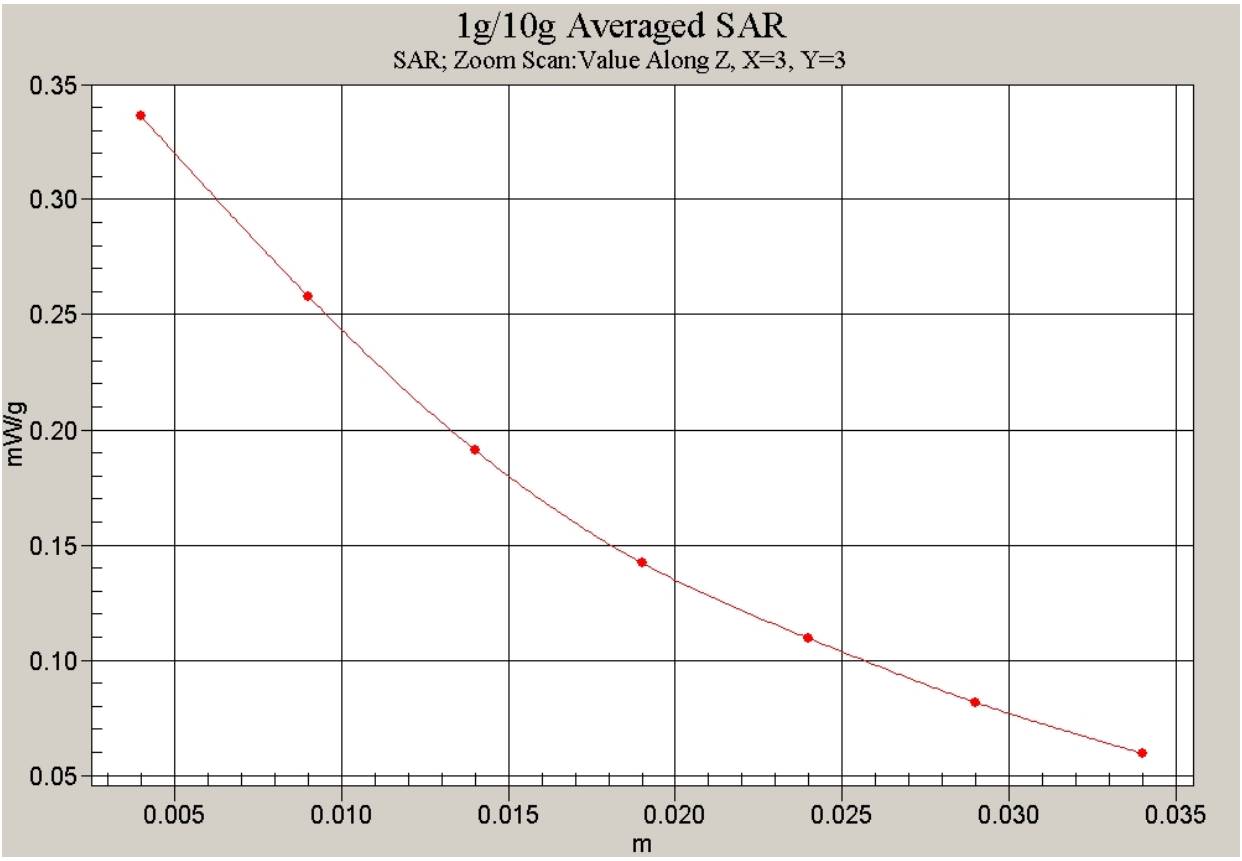


Fig. 30 Z-Scan at power reference point (CDMA 835MHz, Body, Towards Phantom, CH1013)

CDMA 1X Body Toward Ground High

Electronics: DAE3 Sn536

Communication System: CDMA 1X-new Frequency: 848.31 MHz Duty Cycle: 1:1

Probe: ET3DV6 - SN1736 ConvF(6.45, 6.45, 6.45)

Toward Ground High/Area Scan (71x121x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.488 mW/g

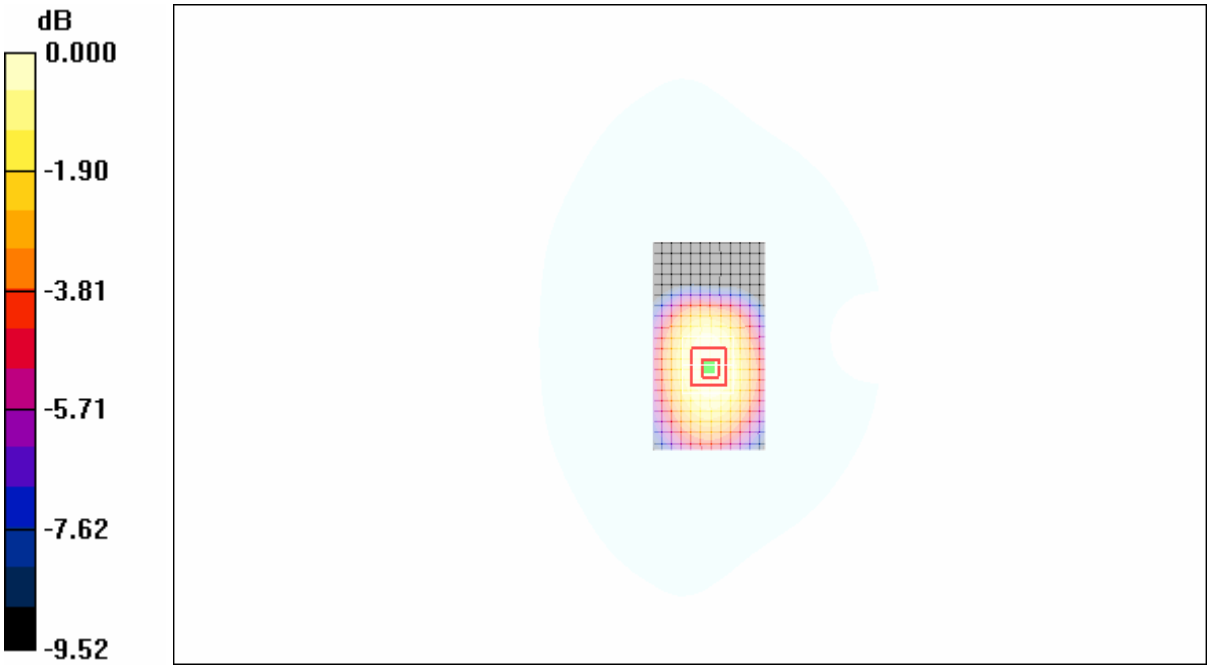
Toward Ground High/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 22.2 V/m; Power Drift = 0.004 dB

Peak SAR (extrapolated) = 0.586 W/kg

SAR(1 g) = 0.460 mW/g; SAR(10 g) = 0.334 mW/g

Maximum value of SAR (measured) = 0.487 mW/g



0 dB = 0.487mW/g

Fig. 31 CDMA 835MHz, Body, Towards Ground, CH777

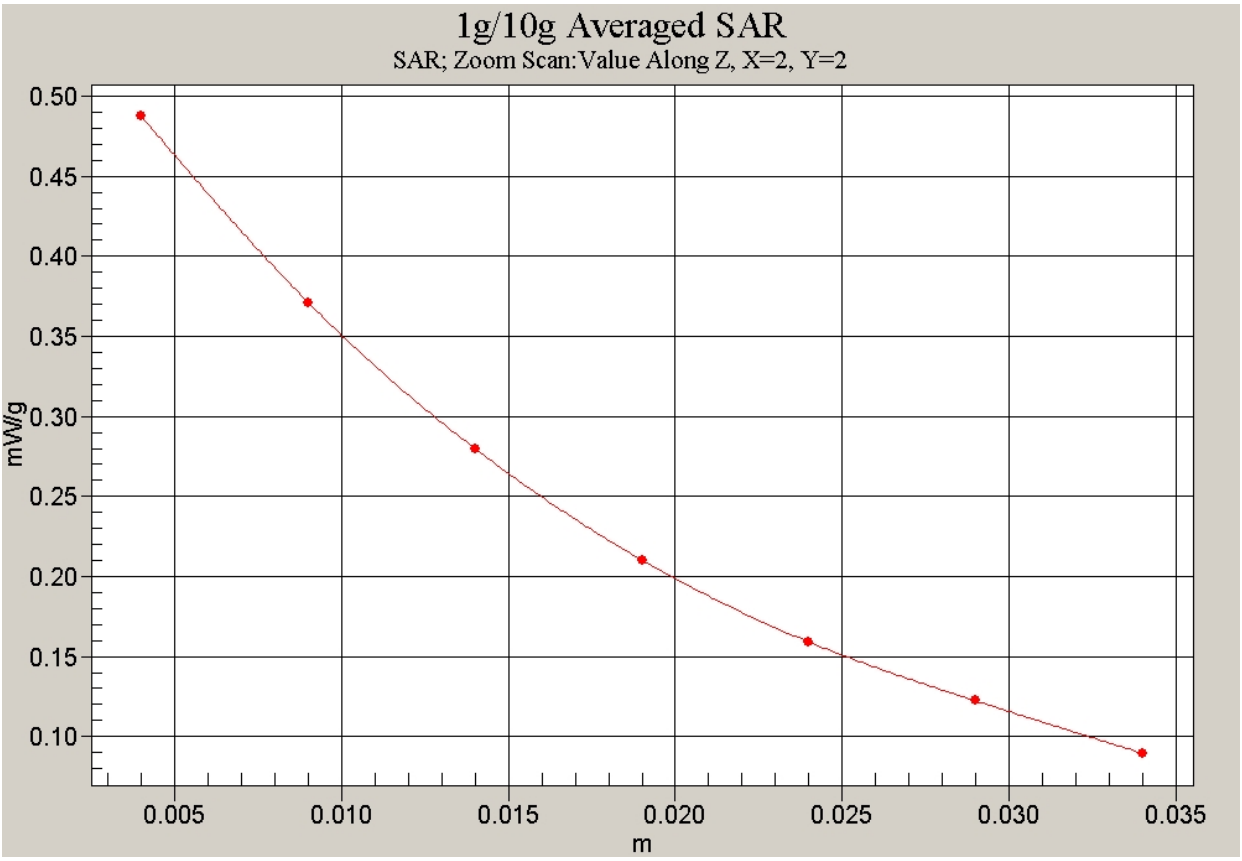


Fig. 232 Z-Scan at power reference point (CDMA 835MHz, Body, Towards Ground, CH777)

CDMA 1X Body Toward Ground Middle

Electronics: DAE3 Sn536

Communication System: CDMA 1X-new Frequency: 836.52 MHz Duty Cycle: 1:1

Probe: ET3DV6 - SN1736 ConvF(6.45, 6.45, 6.45)

Toward Ground Middle/Area Scan (71x121x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.605 mW/g

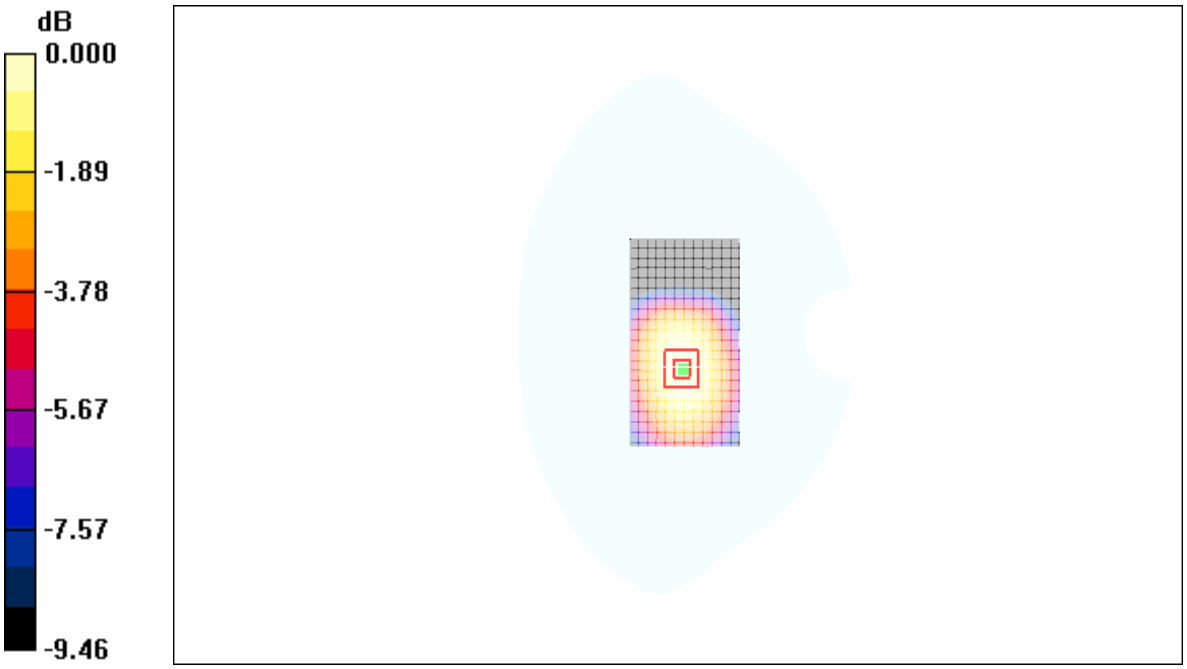
Toward Ground Middle/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 24.1 V/m; Power Drift = 0.087 dB

Peak SAR (extrapolated) = 0.725 W/kg

SAR(1 g) = 0.576 mW/g; SAR(10 g) = 0.420 mW/g

Maximum value of SAR (measured) = 0.612 mW/g



0 dB = 0.612mW/g

Fig. 33 CDMA 835MHz, Body, Towards Ground, CH384

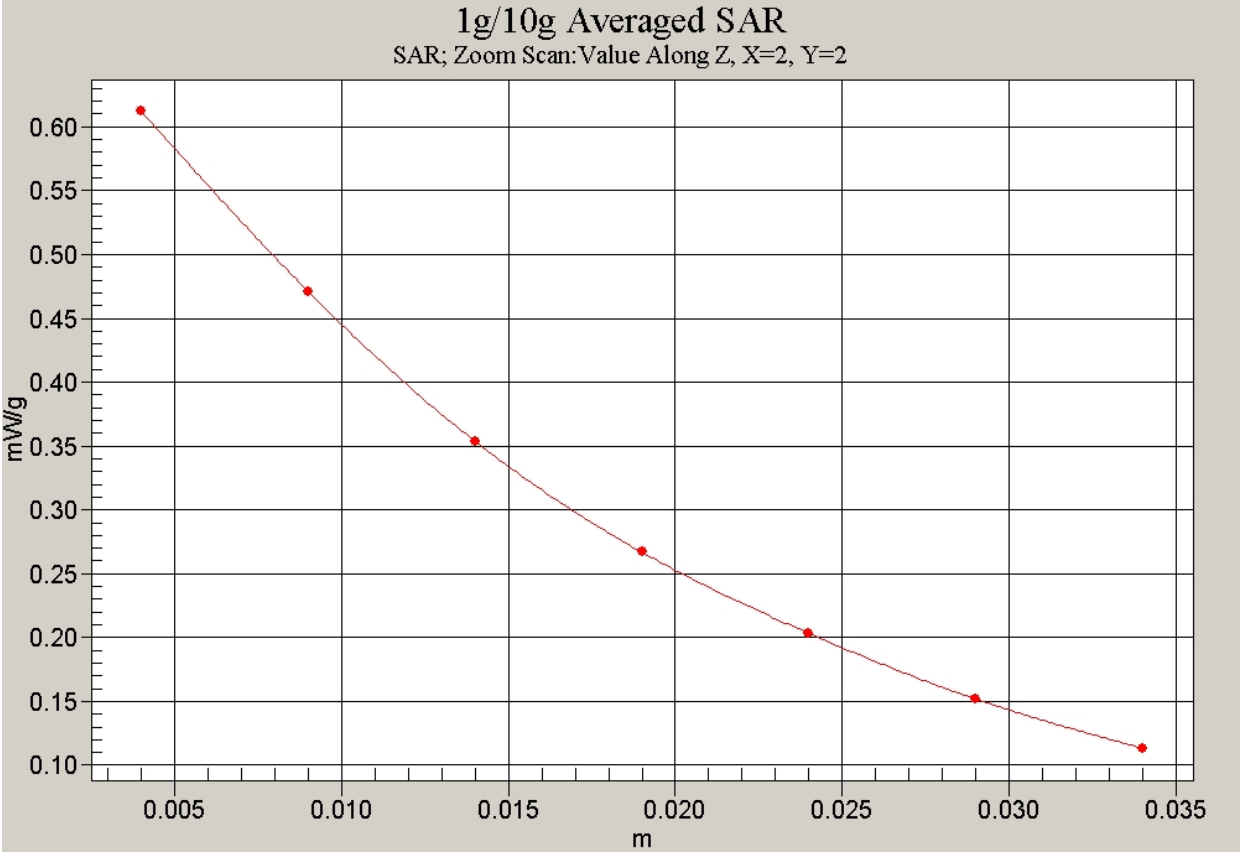


Fig. 34 Z-Scan at power reference point (CDMA 835MHz, Body, Towards Ground, CH384)

CDMA 1X Body Toward Ground Low

Electronics: DAE3 Sn536

Communication System: CDMA 1X-new Frequency: 824.7 MHz Duty Cycle: 1:1

Probe: ET3DV6 - SN1736 ConvF(6.45, 6.45, 6.45)

Toward Ground Low/Area Scan (71x121x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.511 mW/g

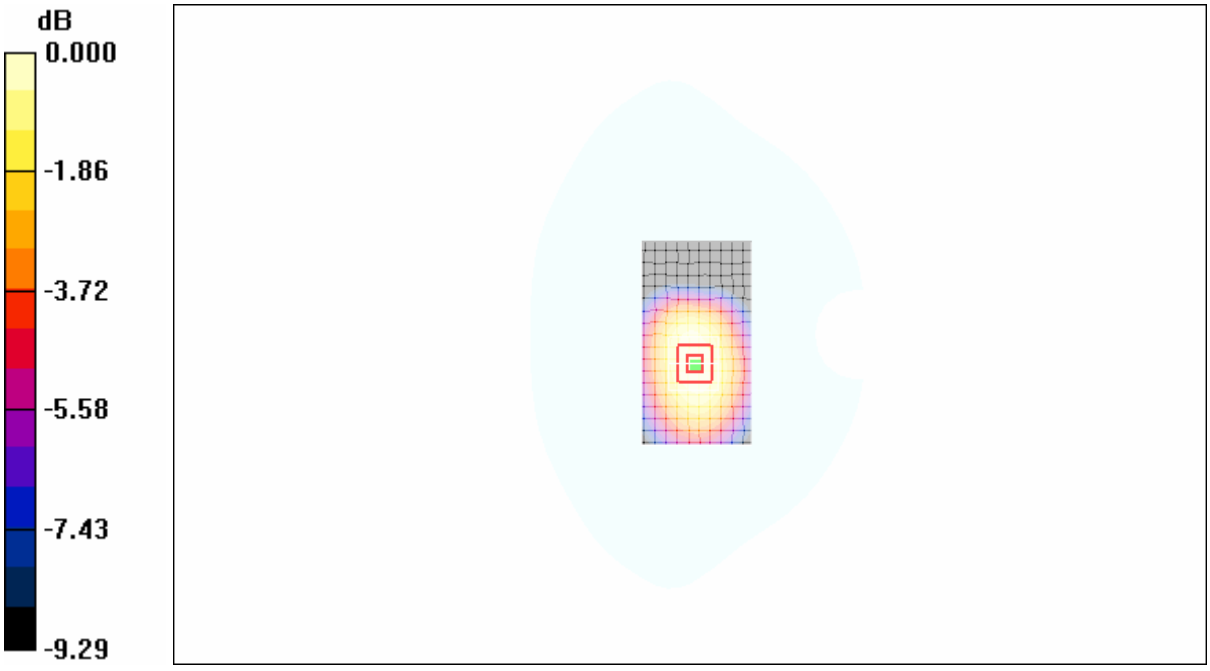
Toward Ground Low/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 23.0 V/m; Power Drift = -0.011 dB

Peak SAR (extrapolated) = 0.614 W/kg

SAR(1 g) = 0.483 mW/g; SAR(10 g) = 0.353 mW/g

Maximum value of SAR (measured) = 0.513 mW/g



0 dB = 0.513mW/g

Fig. 35 CDMA 835MHz, Body, Towards Ground, CH1013

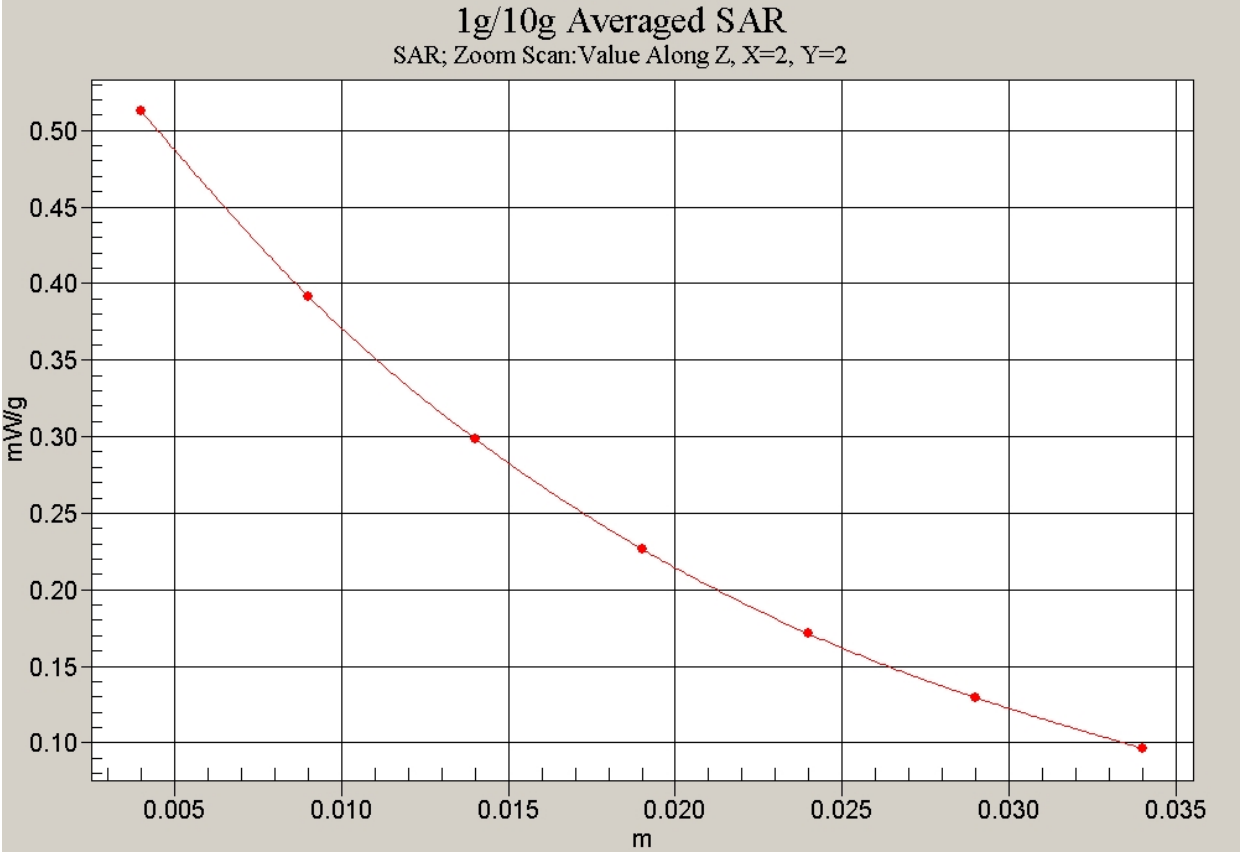


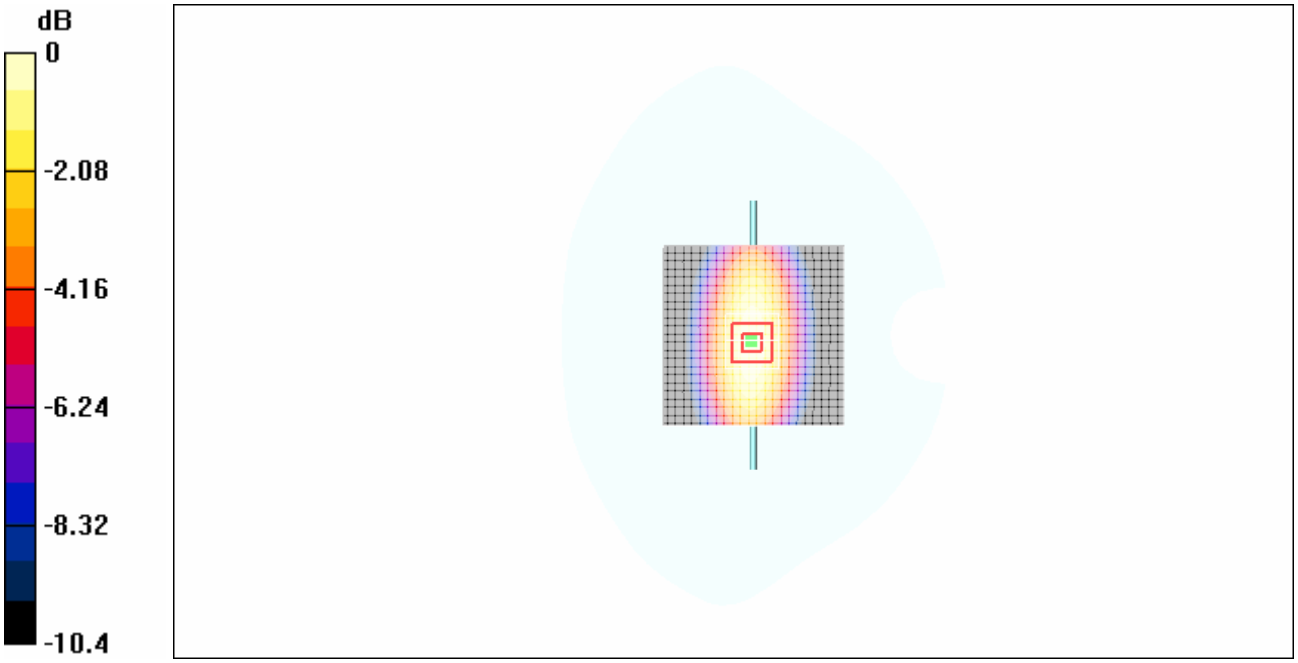
Fig. 36 Z-Scan at power reference point (CDMA 835MHz, Body, Towards Ground, CH1013)

ANNEX D SYSTEM VALIDATION RESULTS

835MHzDAE536Probe1736

Electronics: DAE3 Sn536
Communication System: CW Frequency: 835 MHz Duty Cycle: 1:1
Probe: ET3DV6 - SN1736 ConvF(6.51, 6.51, 6.51)
835MHz/Area Scan (101x101x1): Measurement grid: dx=10mm, dy=10mm
Reference Value = 56.8 V/m; Power Drift = -0.0 dB
Maximum value of SAR (interpolated) = 2.68 mW/g

835MHz/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm
Reference Value = 56.8 V/m; Power Drift = -0.0 dB
Maximum value of SAR (measured) = 2.69 mW/g
Peak SAR (extrapolated) = 3.67 W/kg
SAR(1 g) = 2.48 mW/g; SAR(10 g) = 1.62 mW/g



0 dB = 2.69mW/g

Fig.37 validation 835MHz 250mW

ANNEX E PROBE CALIBRATION CERTIFICATE

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland

S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Federal Office of Metrology and Accreditation
The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Client TMC-Auden

Certificate No: ET3-1736_Nov05

CALIBRATION CERTIFICATE

Object	ET3DV6 - SN:1736
Calibration procedure(s)	QA CAL-01.v5 Calibration procedure for dosimetric E-field probes
Calibration date:	November 25, 2005
Condition of the calibrated item	In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	3-May-05 (METAS, No. 251-00466)	May-06
Power sensor E4412A	MY41495277	3-May-05 (METAS, No. 251-00466)	May-06
Power sensor E4412A	MY41498087	3-May-05 (METAS, No. 251-00466)	May-06
Reference 20 dB Attenuator	SN: S5086 (20b)	3-May-05 (METAS, No. 251-00467)	May-06
Reference Probe ES3DV2	SN: S5086 (20b)	3-May-05 (METAS, No. 251-00467)	May-06
DAE4	SN: 3013	7-Jan-05 (SPEAG, No. ES3-3013_Jan05)	Jan-06
Reference Probe ES3DV2	SN: 907	21-Jun-05 (SPEAG, No. DAE4-907_Jun05)	Jun-06

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (SPEAG, in house check Dec-03)	In house check: Dec-05
Network Analyzer HP 8753E	US37390585	18-Oct-01 (SPEAG, in house check Nov-04)	In house check: Nov 05

	Name	Function	Signature
Calibrated by:	Nico Vetterli	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	

Issued: November 25, 2005

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland

S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Federal Office of Metrology and Accreditation
The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Glossary:

TSL	tissue simulating liquid
NORMx,y,z	sensitivity in free space
ConF	sensitivity in TSL / NORMx,y,z
DCP	diode compression point
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., ϑ = 0 is normal to probe axis

Calibration is Performed According to the Following Standards:

a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
b) CENELEC EN 50361, "Basic standard for the measurement of Specific Absorption Rate related to human exposure to electromagnetic fields from mobile phones (300 MHz - 3 GHz), July 2001

Methods Applied and Interpretation of Parameters:

- *NORMx,y,z:* Assessed for E-field polarization ϑ = 0 (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not effect the E^2-field uncertainty inside TSL (see below *ConvF*).
- *NORM(f)x,y,z = NORMx,y,z * frequency_response* (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of *ConvF*.
- *DCPx,y,z:* DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- *ConvF and Boundary Effect Parameters:* Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to *NORMx,y,z * ConvF* whereby the uncertainty corresponds to that given for *ConvF*. A frequency dependent *ConvF* is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- *Spherical isotropy (3D deviation from isotropy)*: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- *Sensor Offset*: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

Probe ET3DV6

SN:1736

Manufactured:	September 27, 2002
Last calibrated:	July 14, 2005
Recalibrated:	November 25, 2005

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

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DASY - Parameters of Probe: ET3DV6 SN:1736

Sensitivity in Free Space[A] Diode Compression[B]

NormX	**1.97** ± 10.1%	$\mu V/(V/m)^2$	DCP X	**93** mV
NormY	**1.75** ± 10.1%	$\mu V/(V/m)^2$	DCP Y	**93** mV
NormZ	**1.97** ± 10.1%	$\mu V/(V/m)^2$	DCP Z	**93** mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

TSL **900 MHz** **Typical SAR gradient: 5 % per mm**

Sensor Center to Phantom Surface Distance		**3.7 mm**	**4.7 mm**
SAR_{be} [%]	Without Correction Algorithm	9.6	5.0
SAR_{be} [%]	With Correction Algorithm	0.1	0.3

TSL **1810 MHz** **Typical SAR gradient: 10 % per mm**

Sensor Center to Phantom Surface Distance		**3.7 mm**	**4.7 mm**
SAR_{be} [%]	Without Correction Algorithm	13.2	8.8
SAR_{be} [%]	With Correction Algorithm	0.6	0.1

Sensor Offset

Probe Tip to Sensor Center	**2.7** mm

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

[A] The uncertainties of NormX,Y,Z do not affect the E^2-field uncertainty inside TSL (see Page 8).

[B] Numerical linearization parameter: uncertainty not required.

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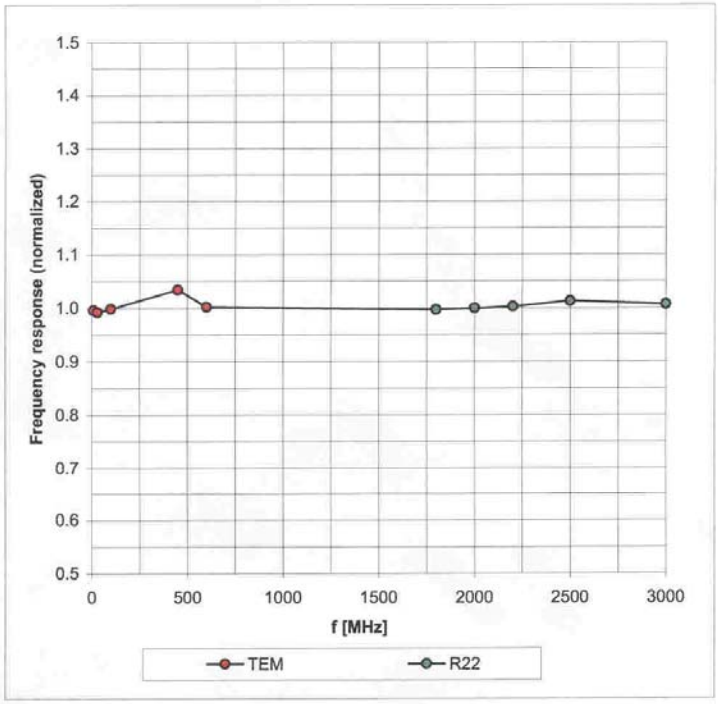
Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

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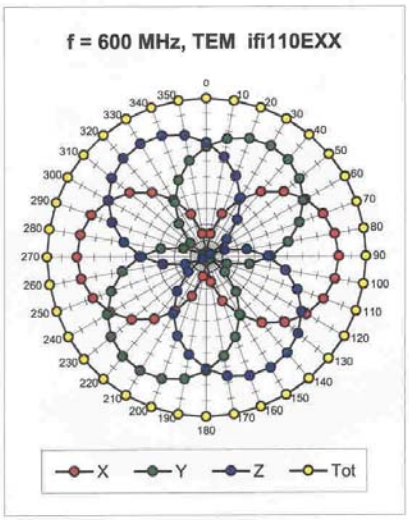
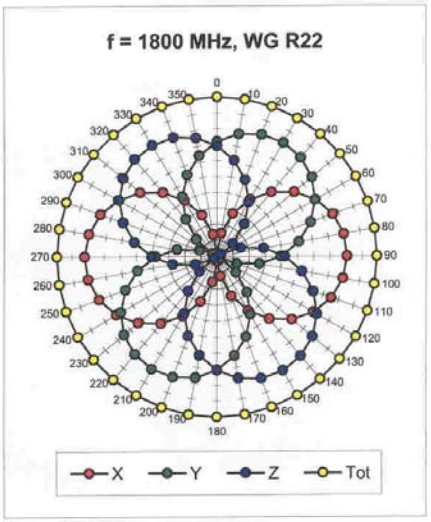
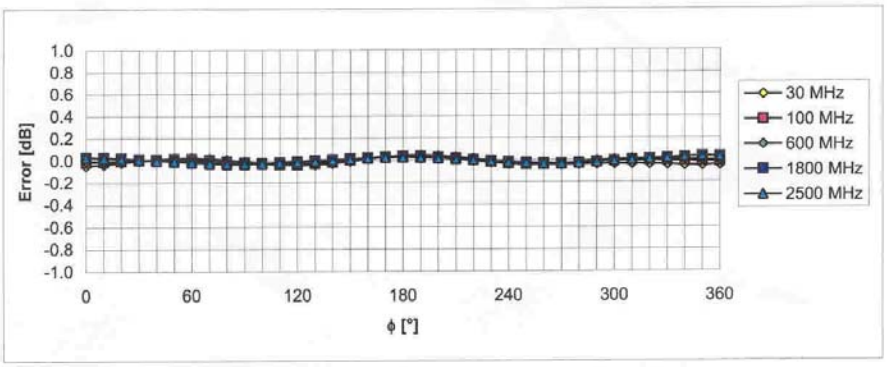
Receiving Pattern (ϕ), ϑ = 0°







Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

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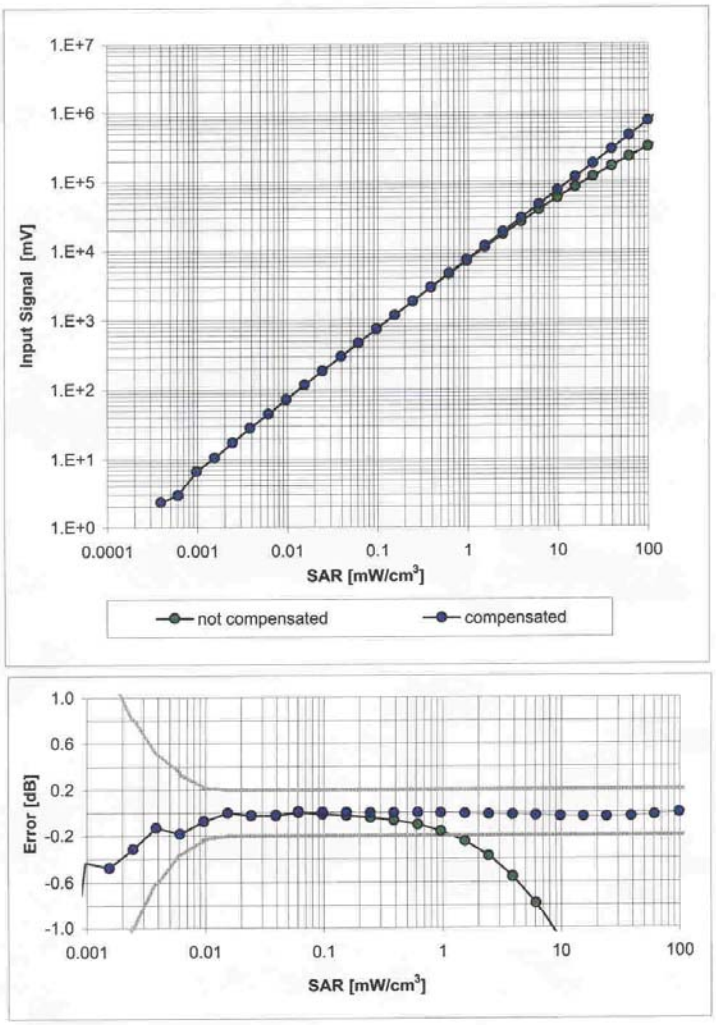
Dynamic Range f(SAR_{head})

(Waveguide R22, f = 1800 MHz)



Uncertainty of Linearity Assessment: ± 0.6% (k=2)

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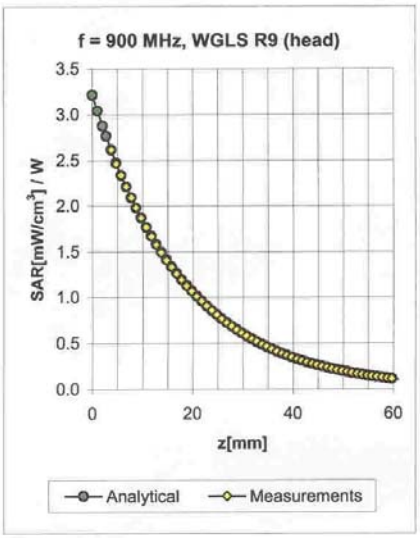
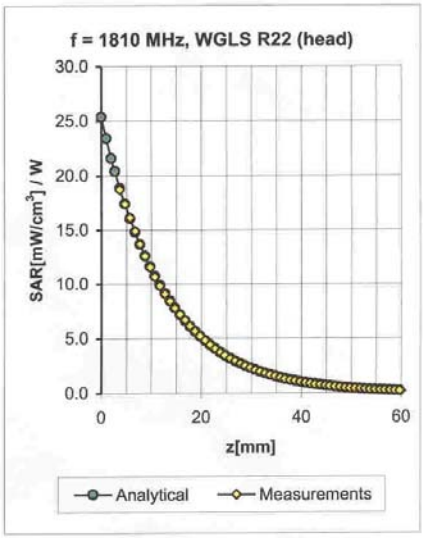
Conversion Factor Assessment





f [MHz]	Validity [MHz][C]	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
900	± 50 / ± 100	Head	41.5 ± 5%	0.97 ± 5%	0.56	1.85	6.51 ± 11.0% (k=2)
1810	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.57	2.47	5.40 ± 11.0% (k=2)
2450	± 50 / ± 100	Head	39.2 ± 5%	1.80 ± 5%	0.62	2.29	4.67 ± 11.8% (k=2)
450	± 50 / ± 100	Body	56.7 ± 5%	0.94 ± 5%	0.12	1.61	7.74 ± 13.3% (k=2)
900	± 50 / ± 100	Body	55.0 ± 5%	1.05 ± 5%	0.47	2.15	6.45 ± 11.0% (k=2)
1810	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.53	2.78	4.88 ± 11.0% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.65	2.11	4.35 ± 11.8% (k=2)

[C] The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

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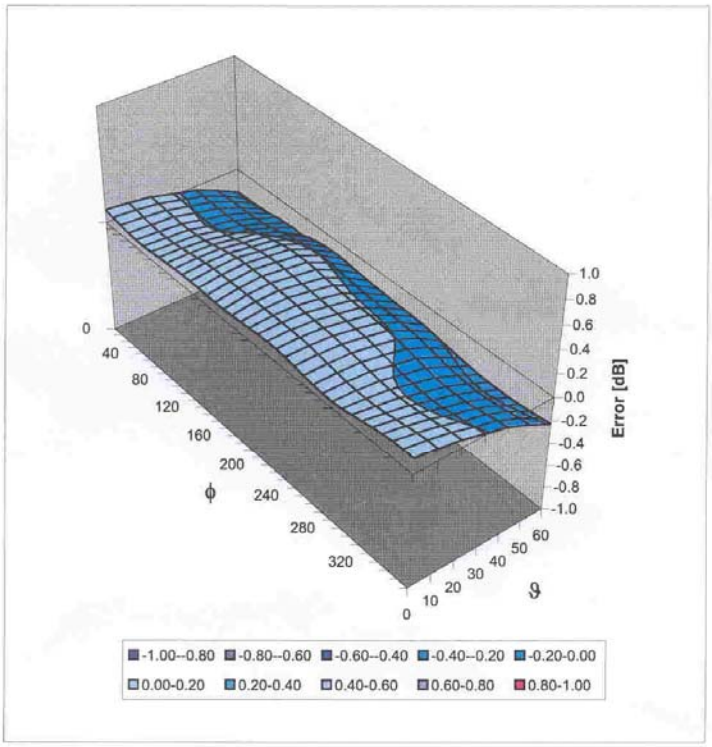
Deviation from Isotropy in HSL

Error (ϕ, ϑ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)